## Application/Control No. Applicant(s)/Patent Under Reexamination 10/823,499 GRUNDY ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Pierre-Michel Bataille 2186 **U.S. PATENT DOCUMENTS** Document Number Country Code-Number-Kind Code Date Name Classification MM-YYYY \* Α US-2002/0159467 10-2002 Kirshenboim et al. 370/410 В US-6,160,823 12-2000 Saintot, Patrice 370/538 С US-5,745,491 04-1998 Ando et al. 370/428 D US-5,515,368 05-1996 Saito et al. 370/428 Ε US-US-F US-G Н US-US-US-J Κ US-US-L US-М FOREIGN PATENT DOCUMENTS

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